

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10600581	HANNA, MICHELLE M.
<b>Examiner</b>	<b>Art Unit</b>	
Young J Kim	1637	

### SEARCHED

Class	Subclass	Date	Examiner

### SEARCH NOTES

Search Notes	Date	Examiner
Patent Databases - updated	8/29/2008	/YJK/
Patent Databases - updated (search note for 10/790,766)	2/17/2009	/YJK/

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
	Interference Databases - see printout	2/17/2009	/YJK/

	/Young J Kim/ Primary Examiner, Art Unit 1637
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